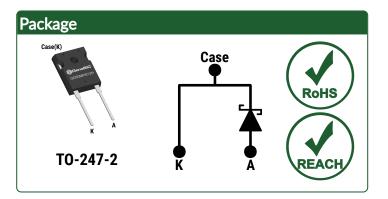
# GeneSic SEMICONDUCTOR

## Silicon Carbide Schottky Diode

VRRM = 1200 V IF (Tc = 147°C) = 50 A Qc = 161 nC

#### **Features**

- Gen4 Thin Chip Technology for Low V<sub>F</sub>
- Enhanced Surge and Avalanche Robustness
- Superior Figure of Merit Qc/IF
- Low Thermal Resistance
- Low Reverse Leakage Current
- Temperature Independent Fast Switching
- Positive Temperature Coefficient of V<sub>F</sub>
- High dV/dt Ruggedness



## **Advantages**

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

## **Applications**

- Electric Vehicles and Fast Chargers
- Solar Inverters
- Train Auxiliary Power Supplies
- High frequency Converters
- Motor Drives
- Induction Heating and Welding
- Uninterruptible Power Supplies
- Pulsed Power

Absolute Maximum Ratings (At T <sub>C</sub> = 25°C Unless Otherwise Stated)								
Parameter	Symbol	Conditions	Values	Unit	Note			
Repetitive Peak Reverse Voltage	$V_{RRM}$		1200	٧				
		$T_C = 100^{\circ}C, D = 1$	92					
Continuous Forward Current	l <sub>F</sub>	$T_C = 135^{\circ}C, D = 1$	63	Α	Fig. 4			
		$T_C = 147^{\circ}C, D = 1$	50					
Non-Repetitive Peak Forward Surge Current, Half Sine	1	$T_C = 25^{\circ}C$ , $t_P = 10 \text{ ms}$	500	А				
Wave	I <sub>F,SM</sub>	$T_C = 150$ °C, $t_P = 10$ ms	400					
Repetitive Peak Forward Surge Current, Half Sine Wave	1	$T_C = 25^{\circ}C$ , $t_P = 10 \text{ ms}$	300	^				
Repetitive Feak Forward Surge Current, Hair Sine Wave	I <sub>F,RM</sub>	$T_C = 150$ °C, $t_P = 10$ ms	210	Α				
Non-Repetitive Peak Forward Surge Current	I <sub>F,MAX</sub>	$T_C$ = 25°C, $t_P$ = 10 $\mu$ s	2500	Α				
i <sup>2</sup> t Value	∫i²dt	$T_C = 25^{\circ}C$ , $t_P = 10 \text{ ms}$	1250	A <sup>2</sup> s				
Non-Repetitive Avalanche Energy	E <sub>AS</sub>	$L = 0.4 \text{ mH}, I_{AS} = 50 \text{ A}$	541	mJ				
Diode Ruggedness	dV/dt	V <sub>R</sub> = 0 ~ 960 V	200	V/ns				
Power Dissipation	P <sub>TOT</sub>	T <sub>C</sub> = 25°C	519	W	Fig. 3			
Operating and Storage Temperature	$T_j$ , $T_{stg}$		-55 to 175	°C				

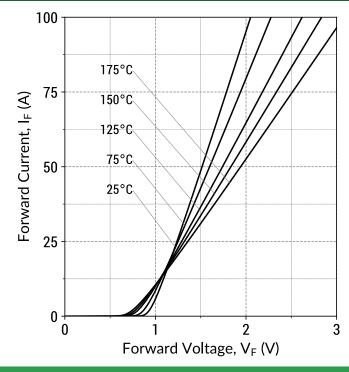


Electrical Characteristics								
Parameter	Symbol	Conditions		Values			Unit	Note
raidiletei	Зунион			Min.	Тур.	Max.	Ullit	Note
Diode Forward Voltage V <sub>F</sub>		$I_F = 50 \text{ A, } T_j = 25^{\circ}\text{C}$			1.5	1.8	V	Eig 1
Diode Forward Voltage	VF	$I_F = 50 \text{ A, } T_j = 175^{\circ}\text{C}$			1.9		٧	Fig. 1
Reverse Current	l <sub>s</sub>	V <sub>R</sub> = 1200 V, T <sub>j</sub> = 25°C			3	15	μA	Fig. 2
	IR	V <sub>R</sub> = 1200 V, 1	T <sub>j</sub> = 175°C		33		μА	
Total Capacitive Charge	Qc		$V_{R} = 400 V$		111		nC	Fig. 7
	QC	I <sub>F</sub> ≤ I <sub>F,MAX</sub>	$V_R = 800 V$		161			
Switching Time	ts	$dI_F/dt = 200 \text{ A/}\mu\text{s}$ $V_R = 400 \text{ V}$			< 10		no	
	ιs		$V_{R} = 800 V$		<b>\ 10</b>		ns	
Total Capacitance	С	$V_R$ = 1 V, f = 1MHz $V_R$ = 800 V, f = 1MHz			1835		pF	Fig. 6
					107			

Thermal/Package Characteristics							
Parameter	Symbol	Conditions	Values			Unit	Note
		Colluitions	Min.	Тур.	Max.	UIIIL	Note
Thermal Resistance, Junction - Case	$R_{thJC}$			0.29		°C/W	Fig. 9
Weight	W <sub>T</sub>			6.0		g	
Mounting Torque	Тм	Screws to Heatsink			1.1	Nm	

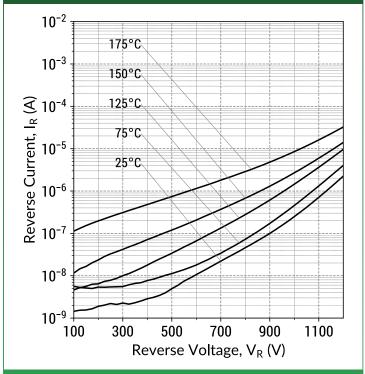






 $I_F = f(V_F, T_j); t_P = 250 \mu s$ 

**Figure 2: Typical Reverse Characteristics** 



 $I_R = f(V_R, T_j)$ 

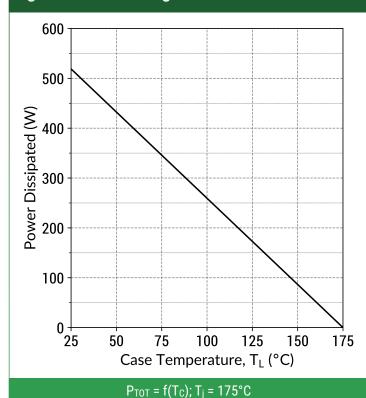
Figure 4: Current Derating Curves (Typical V<sub>F</sub>)

400

300

0 + 25

**Figure 3: Power Derating Curves** 



Current Rating (A) 00 00 D = 0.7 D = 1 100

75

50

 $I_F = f(T_C); D = t_P/T; T_j \le 175^{\circ}C; f_{SW} > 10kHz$ 

100

Case Temperature, T<sub>C</sub> (°C)

125

150

175

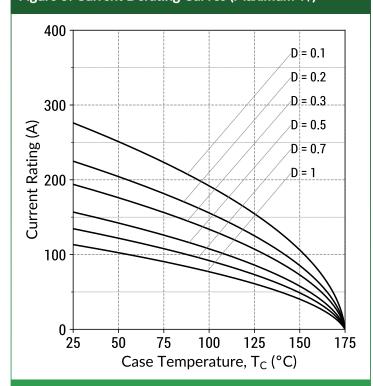
D = 0.1D = 0.2

D = 0.3

D = 0.5

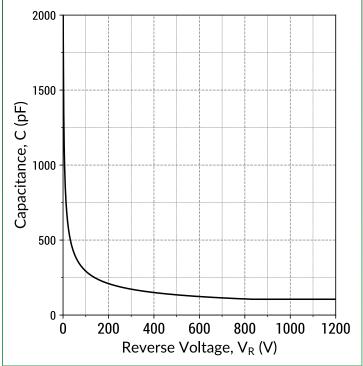


Figure 5: Current Derating Curves (Maximum V<sub>F</sub>)



 $I_F = f(T_C); D = t_P/T; T_j \le 175^{\circ}C; f_{SW} > 10kHz$ 

Figure 6: Typical Junction Capacitance vs Reverse Voltage Characteristics



 $C = f(V_R)$ ; f = 1MHz

Figure 7: Typical Capacitive Charge vs Reverse Voltage Characteristics

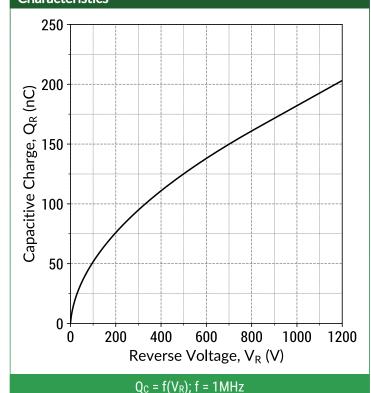
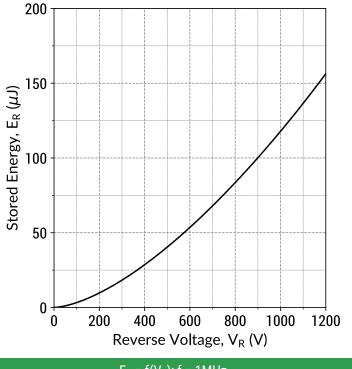


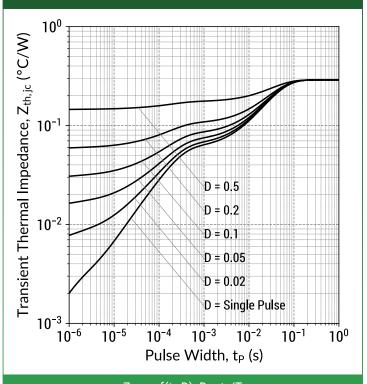
Figure 8: Typical Capacitive Energy vs Reverse Voltage Characteristics



 $E_C = f(V_R)$ ; f = 1MHz

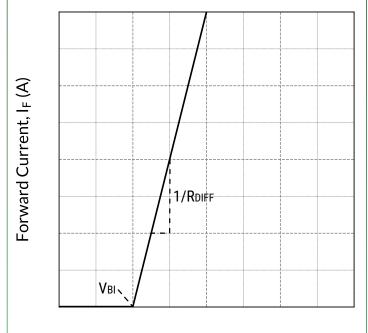


Figure 9: Transient Thermal Impedance



## $Z_{th,jc} = f(t_P,D); D = t_P/T$

## Figure 10: Forward Curve Model



Forward Voltage,  $V_F(V)$ 

 $I_F = f(V_F, T_j)$ 

## Forward Curve Model Equation:

 $I_F = (V_F - V_{BI})/R_{DIFF}(A)$ 

## Built-In Voltage (V<sub>BI</sub>):

$$V_{BI}(T_j) = m \times T_j + n (V)$$
  
 $m = -0.00119 (V/^{\circ}C)$   
 $n = 1.01 (V)$ 

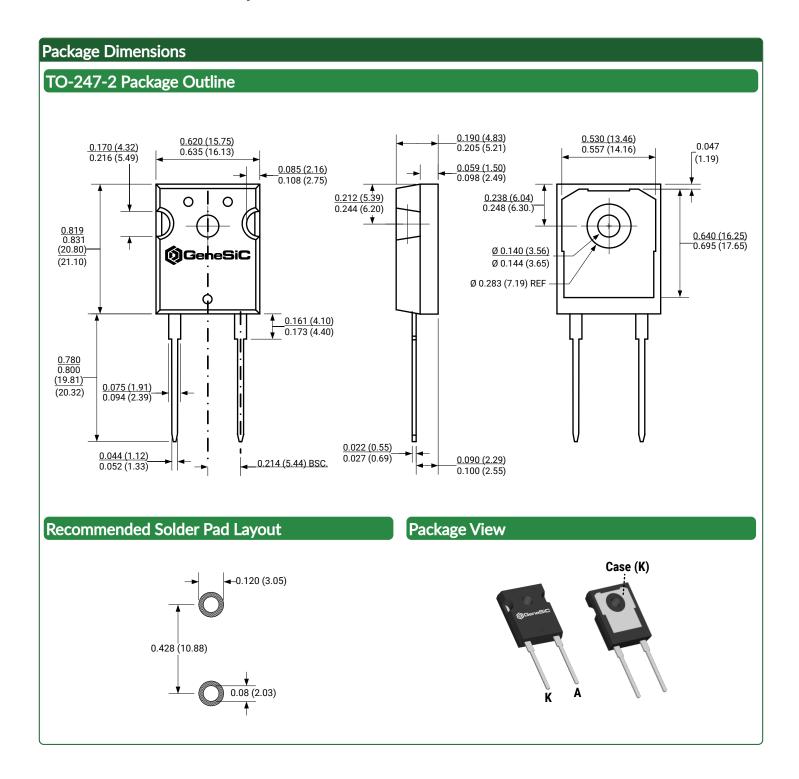
## Differential Resistance (RDIFF):

$$R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c (\Omega)$$
  
 $a = 2.38e-07 (\Omega/^{\circ}C^2)$   
 $b = 3.3e-05 (\Omega/^{\circ}C)$   
 $c = 0.00979 (\Omega)$ 

## **Forward Power Loss Equation:**

 $P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$ 





#### **NOTE**

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.





## Compliance

#### **RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

#### **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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#### **Related Links**

SPICE Models: https://www.genesicsemi.com/sic-schottky-mps/GD50MPS12H/GD50MPS12H\_SPICE.zip
 PLECS Models: https://www.genesicsemi.com/sic-schottky-mps/GD50MPS12H/GD50MPS12H\_PLECS.zip
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#### **Revision History**

Date	Revision	Comments	Supersedes
Jul. 27, 2020	Rev 1	Initial Release	



www.genesicsemi.com/sic-schottky-mps/

